

TEST REPORT

Product Name : TWS Bluetooth earphones
Brand Mark : N/A
Model No. : In2029A
FCC ID : RDR-IN2029A
Report Number : BLA-EMC-202011-A10202
Date of Sample Receipt : 2020/11/30
Date of Test : 2020/11/30 to 2020/12/14
Date of Issue : 2020/12/14
Test Standard : 47 CFR Part 15, Subpart C 15.247
Test Result : Pass

Prepared for:

Dongguan Hele Electronics Co.,Ltd

Dalingya Industrial Zone, Daojiao Town, Dongguan City, Guangdong, China

Prepared by:

BlueAsia of Technical Services(Shenzhen) Co.,Ltd.

IOT Test Centre of BlueAsia

No. 448 Bulong Road, Bantian Street, Longgang District, Shenzhen, China

TEL: +86-755-23059481

Compiled by:

Jason

Review by:

Sweet. Liang

Approved by:

Kevin Li

Date:

2020/12/14



REPORT REVISE RECORD

Version No.	Date	Description
00	2020/12/14	Original

BlueAsia

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1 TEST SUMMARY

Test item	Test Requirement	Test Method	Class/Severity	Result
Antenna Requirement	47 CFR Part 15, Subpart C 15.247	N/A	47 CFR Part 15, Subpart C 15.203 & 15.247(c)	Pass
Conducted Spurious Emissions	47 CFR Part 15, Subpart C 15.247	ANSI C63.10 (2013) Section 7.8.6 & Section 11.11	47 CFR Part 15, Subpart C 15.247(d)	Pass
Radiated Emissions which fall in the restricted bands	47 CFR Part 15, Subpart C 15.247	ANSI C63.10 (2013) Section 6.10.5	47 CFR Part 15, Subpart C 15.209 & 15.247(d)	Pass
Conducted Band Edges Measurement	47 CFR Part 15, Subpart C 15.247	ANSI C63.10 (2013) Section 7.8.8 & Section 11.13.3.2	47 CFR Part 15, Subpart C 15.247(d)	Pass
Dwell Time	47 CFR Part 15, Subpart C 15.247	ANSI C63.10 (2013) Section 7.8.4	47 CFR Part 15, Subpart C 15.247a(1)(iii)	Pass
Hopping Channel Number	47 CFR Part 15, Subpart C 15.247	ANSI C63.10 (2013) Section 7.8.3	47 CFR Part 15, Subpart C 15.247a(1)(iii)	Pass
Carrier Frequencies Separation	47 CFR Part 15, Subpart C 15.247	ANSI C63.10 (2013) Section 7.8.2	47 CFR Part 15, Subpart C 15.247a(1)	Pass
20dB Bandwidth	47 CFR Part 15, Subpart C 15.247	ANSI C63.10 (2013) Section 7.8.7	47 CFR Part 15, Subpart C 15.247(a)(1)	Pass
Conducted Peak Output Power	47 CFR Part 15, Subpart C 15.247	ANSI C63.10 (2013) Section 7.8.5	47 CFR Part 15, Subpart C 15.247(b)(3)	Pass
Conducted Emissions at AC Power Line (150kHz-30MHz)	47 CFR Part 15, Subpart C 15.247	ANSI C63.10 (2013) Section 6.2	47 CFR Part 15, Subpart C 15.207	Pass
Radiated Spurious Emissions	47 CFR Part 15, Subpart C 15.247	ANSI C63.10 (2013) Section 6.4,6.5,6.6	47 CFR Part 15, Subpart C 15.209 & 15.247(d)	Pass

2 GENERAL INFORMATION

Applicant	Dongguan Hele Electronics Co.,Ltd
Address	Dalingya Industrial Zone,DaojiaoTown,DongguanCity,Guangdong,China
Manufacturer	Dongguan Hele Electronics Co.,Ltd
Address	Dalingya Industrial Zone,DaojiaoTown,DongguanCity,Guangdong,China
Factory	N/A
Address	N/A
Product Name	TWS Bluetooth earphones
Test Model No.	In2029A

3 GENERAL DESCRIPTION OF E.U.T.

Hardware Version	N/A
Software Version	N/A
Operation Frequency:	2402MHz-2480MHz
Modulation Type:	GFSK, $\pi/4$ DQPSK
Channel Spacing:	1MHz
Number of Channels:	79
Antenna Type:	Chip Antenna
Antenna Gain:	0.4 dBi(Provided by the customer)

4 TEST ENVIRONMENT

Environment	Temperature	Voltage
Normal	+25°C	3.7Vdc

5 TEST MODE

TEST MODE	TEST MODE DESCRIPTION
Transmitting mode	Keep the EUT in continuously transmitting mode with modulation. (hopping and non hopping mode all have been tested, non hopping mode is worse case for RE)
TX Low channel	Keep the EUT in continuously transmitting mode in low channel
TX middle channel	Keep the EUT in continuously transmitting mode in middle channel
TX high channel	Keep the EUT in continuously transmitting mode in high channel
Remark: Full battery is used during all test except ac conducted emission, DH1,DH3, DH5 all have been tested, during the test, GFSK, Pi/4QPSK modulation were all pre-scanned Only Pi/4QPSK is the worst mode and would be recorded in this report.	

6 MEASUREMENT UNCERTAINTY

Parameter	Expanded Uncertainty (Confidence of 95%)
Radiated Emission(9kHz-30MHz)	±4.34dB
Radiated Emission(30Mz-1000MHz)	±4.24dB
Radiated Emission(1GHz-18GHz)	±4.68dB
AC Power Line Conducted Emission(150kHz-30MHz)	±3.45dB

7 DESCRIPTION OF SUPPORT UNIT

Device Type	Manufacturer	Model Name	Serial No.	Remark
AC Adapter	UGREEN	CD112	N/A	N/A

8 LABORATORY LOCATION

All tests were performed at:
BlueAsia of Technical Services(Shenzhen) Co., Ltd.
IOT Test Centre of BlueAsia
No. 448 Bulong Road, Bantian Street, Longgang District, Shenzhen, China
Telephone: TEL: +86-755-28682673 FAX: +86-755-28682673
No tests were sub-contracted.

9 TEST INSTRUMENTS LIST

Test Equipment Of Conducted Spurious Emissions					
Equipment	Manufacturer	Model	S/N	Cal.Date	Cal.Due
Spectrum	R&S	FSP40	100817	7/1/2020	6/30/2021
Spectrum	Agilent	N9020A	MY49100060	12/17/2019	12/16/2020
Signal Generator	Agilent	N5182A	MY49060650	12/17/2019	12/16/2020
Signal Generator	Agilent	E8257D	MY44320250	4/20/2020	4/19/2021

Test Equipment Of Radiated Emissions which fall in the restricted bands					
Equipment	Manufacturer	Model	S/N	Cal.Date	Cal.Due
Chamber	SKET	966	N/A	5/8/2018	5/7/2021
Spectrum	R&S	FSP40	100817	7/1/2020	6/30/2021
Receiver	R&S	ESR7	101199	4/20/2020	4/19/2021
broadband Antenna	Schwarzbeck	VULB9168	00836 P:00227	7/14/2018	7/13/2021
Horn Antenna	Schwarzbeck	9120D	01892 P:00331	7/14/2018	7/13/2021
Amplifier	SKET	PA-000318G-45	N/A	7/1/2020	6/30/2021
EMI software	EZ	EZ-EMC	N/A	N/A	N/A
Loop antenna	SCHNARZBECK	FMZB1519B	00102	2/14/2019	2/13/2022
Controller	SKET	N/A	N/A	N/A	N/A
Coaxial Cable	BlueAsia	BLA-XC-02	N/A	N/A	N/A
Coaxial Cable	BlueAsia	BLA-XC-03	N/A	N/A	N/A
Coaxial Cable	BlueAsia	BLA-XC-01	N/A	N/A	N/A

Test Equipment Of Conducted Band Edges Measurement					
Equipment	Manufacturer	Model	S/N	Cal.Date	Cal.Due

Spectrum	R&S	FSP40	100817	7/1/2020	6/30/2021
Spectrum	Agilent	N9020A	MY49100060	12/17/2019	12/16/2020
Signal Generator	Agilent	N5182A	MY49060650	12/17/2019	12/16/2020
Signal Generator	Agilent	E8257D	MY44320250	4/20/2020	4/19/2021

Test Equipment Of Dwell Time

Equipment	Manufacturer	Model	S/N	Cal.Date	Cal.Due
Spectrum	R&S	FSP40	100817	7/1/2020	6/30/2021
Spectrum	Agilent	N9020A	MY49100060	12/17/2019	12/16/2020
Signal Generator	Agilent	N5182A	MY49060650	12/17/2019	12/16/2020
Signal Generator	Agilent	E8257D	MY44320250	4/20/2020	4/19/2021

Test Equipment Of Hopping Channel Number

Equipment	Manufacturer	Model	S/N	Cal.Date	Cal.Due
Spectrum	R&S	FSP40	100817	7/1/2020	6/30/2021
Spectrum	Agilent	N9020A	MY49100060	12/17/2019	12/16/2020
Signal Generator	Agilent	N5182A	MY49060650	12/17/2019	12/16/2020
Signal Generator	Agilent	E8257D	MY44320250	4/20/2020	4/19/2021

Test Equipment Of Carrier Frequencies Separation

Equipment	Manufacturer	Model	S/N	Cal.Date	Cal.Due
Spectrum	R&S	FSP40	100817	7/1/2020	6/30/2021
Spectrum	Agilent	N9020A	MY49100060	12/17/2019	12/16/2020
Signal Generator	Agilent	N5182A	MY49060650	12/17/2019	12/16/2020

Signal Generator	Agilent	E8257D	MY44320250	4/20/2020	4/19/2021
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Test Equipment Of 20dB Bandwidth

Equipment	Manufacturer	Model	S/N	Cal.Date	Cal.Due
Spectrum	R&S	FSP40	100817	7/1/2020	6/30/2021
Spectrum	Agilent	N9020A	MY49100060	12/17/2019	12/16/2020
Signal Generator	Agilent	N5182A	MY49060650	12/17/2019	12/16/2020
Signal Generator	Agilent	E8257D	MY44320250	4/20/2020	4/19/2021

Test Equipment Of Conducted Peak Output Power

Equipment	Manufacturer	Model	S/N	Cal.Date	Cal.Due
Spectrum	R&S	FSP40	100817	7/1/2020	6/30/2021
Spectrum	Agilent	N9020A	MY49100060	12/17/2019	12/16/2020
Signal Generator	Agilent	N5182A	MY49060650	12/17/2019	12/16/2020
Signal Generator	Agilent	E8257D	MY44320250	4/20/2020	4/19/2021

Test Equipment Of Conducted Emissions at AC Power Line (150kHz-30MHz)

Equipment	Manufacturer	Model	S/N	Cal.Date	Cal.Due
Shield room	SKET	833	N/A	6/10/2018	6/9/2021
Receiver	R&S	ESPI3	101082	4/20/2020	4/19/2021
LISN	R&S	ENV216	3560.6550.15	7/1/2020	6/30/2021
LISN	AT	AT166-2	AKK1806000003	12/17/2019	12/16/2020
EMI software	EZ	EZ-EMC	N/A	N/A	N/A

Test Equipment Of Radiated Spurious Emissions

Equipment	Manufacturer	Model	S/N	Cal.Date	Cal.Due
Chamber	SKET	966	N/A	5/8/2018	5/7/2021
Spectrum	R&S	FSP40	100817	7/1/2020	6/30/2021
Receiver	R&S	ESR7	101199	4/20/2020	4/19/2021
broadband Antenna	Schwarzbeck	VULB9168	00836 P:00227	7/14/2018	7/13/2021
Horn Antenna	Schwarzbeck	9120D	01892 P:00331	7/14/2018	7/13/2021
Amplifier	SKET	PA-000318G-45	N/A	7/1/2020	6/30/2021
EMI software	EZ	EZ-EMC	N/A	N/A	N/A
Loop antenna	SCHNARZBECK	FMZB1519B	00102	2/14/2019	2/13/2022
Controller	SKET	N/A	N/A	N/A	N/A
Coaxial Cable	BlueAsia	BLA-XC-02	N/A	N/A	N/A
Coaxial Cable	BlueAsia	BLA-XC-03	N/A	N/A	N/A
Coaxial Cable	BlueAsia	BLA-XC-01	N/A	N/A	N/A

1 ANTENNA REQUIREMENT

Test Standard	47 CFR Part 15, Subpart C 15.247
Test Method	N/A

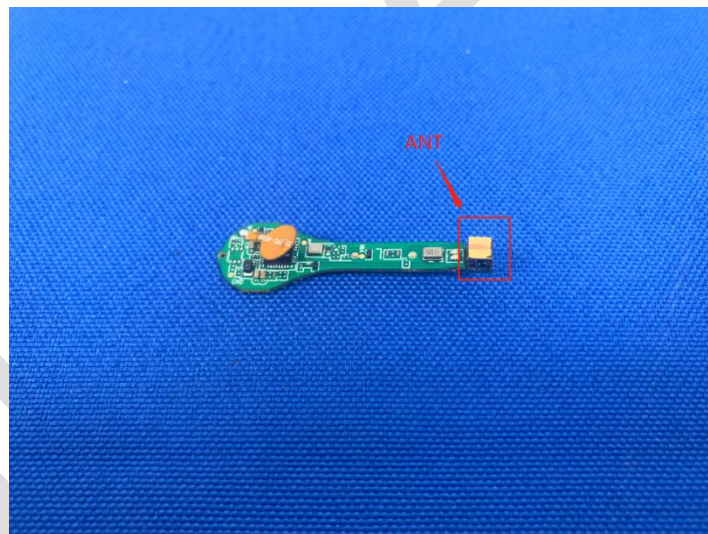
1.1 CONCLUSION

Standard Requirement:

An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of an antenna that uses a unique coupling to the intentional radiator, the manufacturer may design the unit permanently attached antenna or of an so that a broken antenna can be replaced by the user, but the use of a standard antenna jack or electrical connector is prohibited.

EUT Antenna:

The antenna is integrated on the main PCB and no consideration of replacement. The best case gain of the antenna is 0.4dBi.



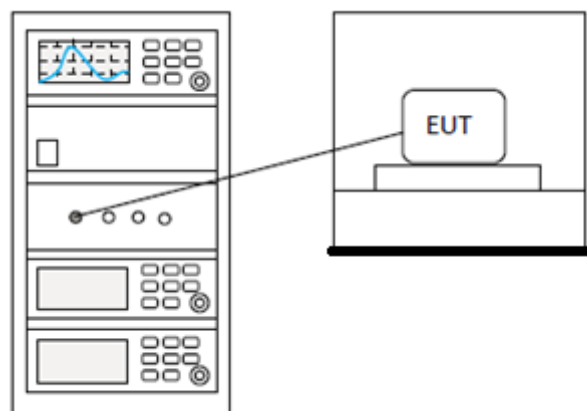
2 CONDUCTED SPURIOUS EMISSIONS

Test Standard	47 CFR Part 15, Subpart C 15.247
Test Method	ANSI C63.10 (2013) Section 7.8.6 & Section 11.11
Test Mode (Pre-Scan)	TX
Test Mode (Final Test)	TX
Tester	Eason
Temperature	25°C
Humidity	60%

2.1 LIMITS

Limit:	In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in §15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in §15.209(a) (see §15.205(c)).
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2.2 BLOCK DIAGRAM OF TEST SETUP



2.3 TEST DATA

Pass: Please Refer To Appendix: For Details

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3 RADIATED EMISSIONS WHICH FALL IN THE RESTRICTED BANDS

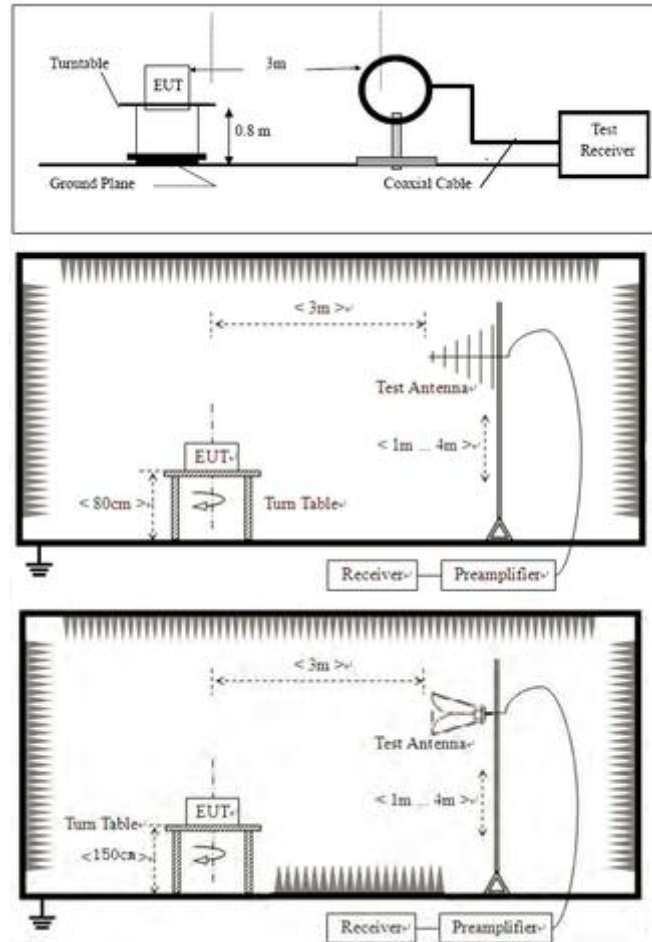
Test Standard	47 CFR Part 15, Subpart C 15.247
Test Method	ANSI C63.10 (2013) Section 6.10.5
Test Mode (Pre-Scan)	TX Low channel;TX middle channel;TX high channel
Test Mode (Final Test)	TX Low channel;TX high channel
Tester	Eason
Temperature	25℃
Humidity	60%

3.1 LIMITS

Frequency(MHz)	Field strength(microvolts/meter)	Measurement distance(meters)
0.009-0.490	2400/F(kHz)	300
0.490-1.705	24000/F(kHz)	30
1.705-30.0	30	30
30-88	100	3
88-216	150	3
216-960	200	3
Above 960	500	3

Remark: The emission limits shown in the above table are based on measurements employing a CISPR quasi-peak detector except for the frequency bands 9-90kHz, 110-490kHz and above 1000 MHz. Radiated emission limits in these three bands are based on measurements employing an average detector, the peak field strength of any emission shall not exceed the maximum permitted average limits specified above by more than 20 dB under any condition of modulation.

3.2 BLOCK DIAGRAM OF TEST SETUP



3.3 PROCEDURE

- For below 1GHz, the EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3 or 10 meter semi-anechoic chamber. The table was rotated 360 degrees to determine the position of the highest radiation.
- For above 1GHz, the EUT was placed on the top of a rotating table 1.5 meters above the ground at a 3 meter fully-anechoic chamber. The table was rotated 360 degrees to determine the position of the highest radiation.
- The EUT was set 3 or 10 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- The antenna height is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters (for the test frequency of below 30MHz, the antenna was tuned to heights 1 meter) and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- The test-receiver system was set to Peak Detect Function and Specified Bandwidth with Maximum Hold Mode.
- If the emission level of the EUT in peak mode was 10dB lower than the limit specified, then testing could be stopped and the peak values of the EUT would be reported. Otherwise the emissions that did not have 10dB margin would be re-tested one by one using peak, quasi-peak or average method as specified and then reported in a data sheet.

- h. Test the EUT in the lowest channel, the middle channel, the Highest channel.
- i. The radiation measurements are performed in X, Y, Z axis positioning for Transmitting mode, and found the X axis positioning which it is the worst case.
- j. Repeat above procedures until all frequencies measured was complete.

Remark 1: $\text{Level} = \text{Read Level} + \text{Cable Loss} + \text{Antenna Factor} - \text{Preamp Factor}$

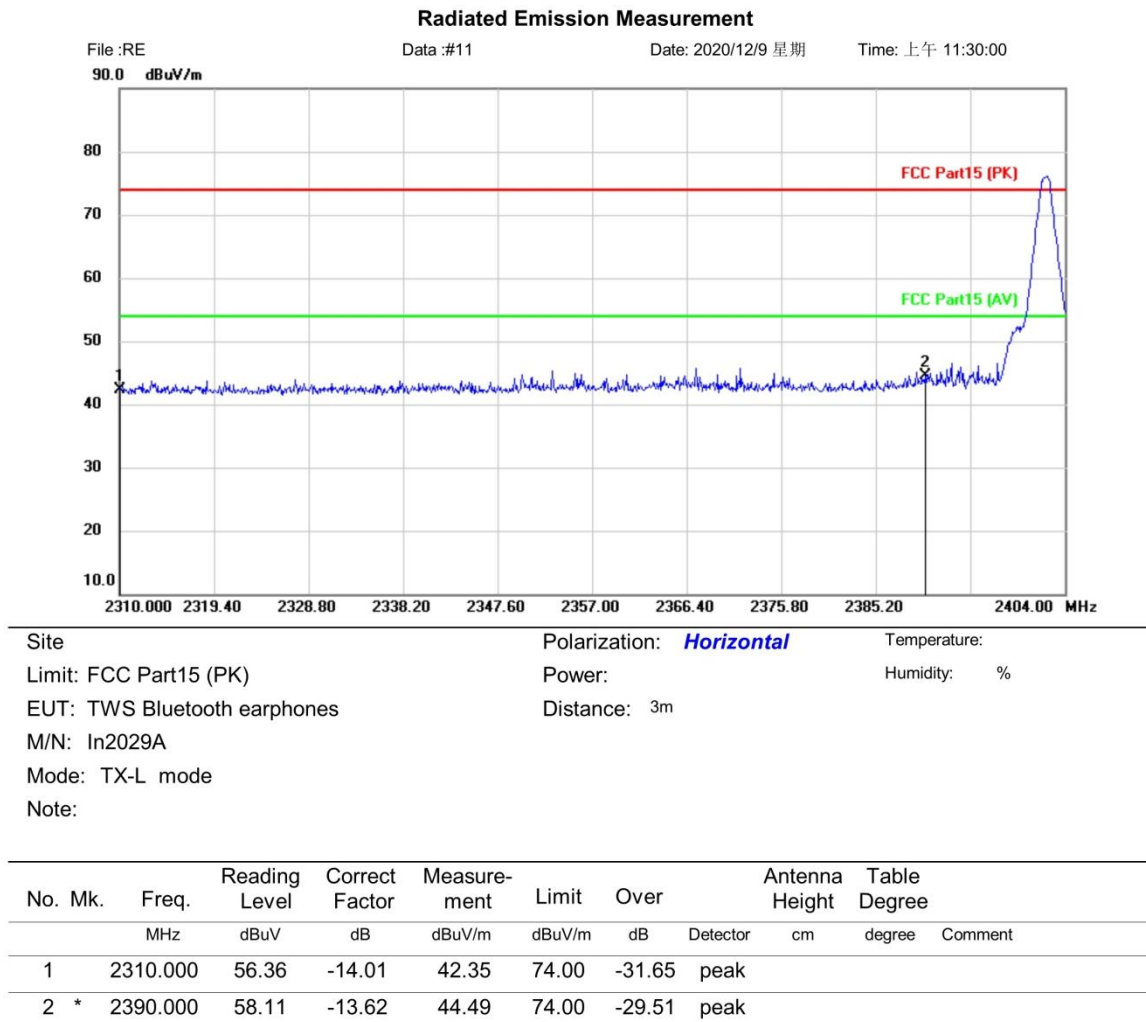
Remark 2: For frequencies above 1GHz, the field strength limits are based on average limits. However, the peak field strength of any emission shall not exceed the maximum permitted average limits specified above by more than 20 dB under any condition of modulation. For the emissions whose peak level is lower than the average limit, only the peak measurement is shown in the report.

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3.4 TEST DATA

Remark: During the test, pre-scan the GFSK, Pi/4QPSK modulation, and found the Pi/4QPSK modulation which it is worse case.

[Test Mode: TX Low channel]; [Polarity: Horizontal]

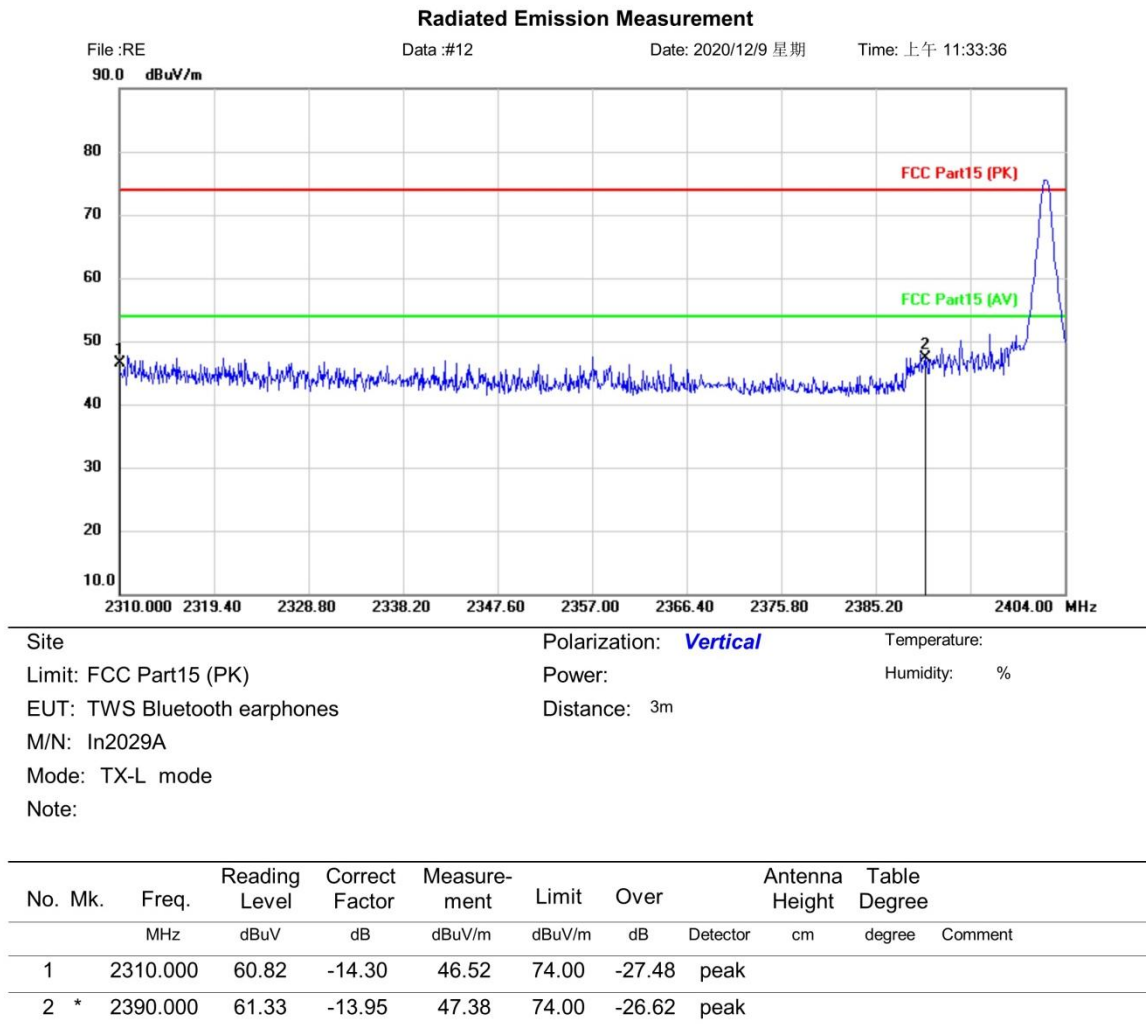


*:Maximum data x:Over limit !:over margin

〈Reference Only

Test Result: Pass

[TestMode: TX Low channel]; [Polarity: Vertical]

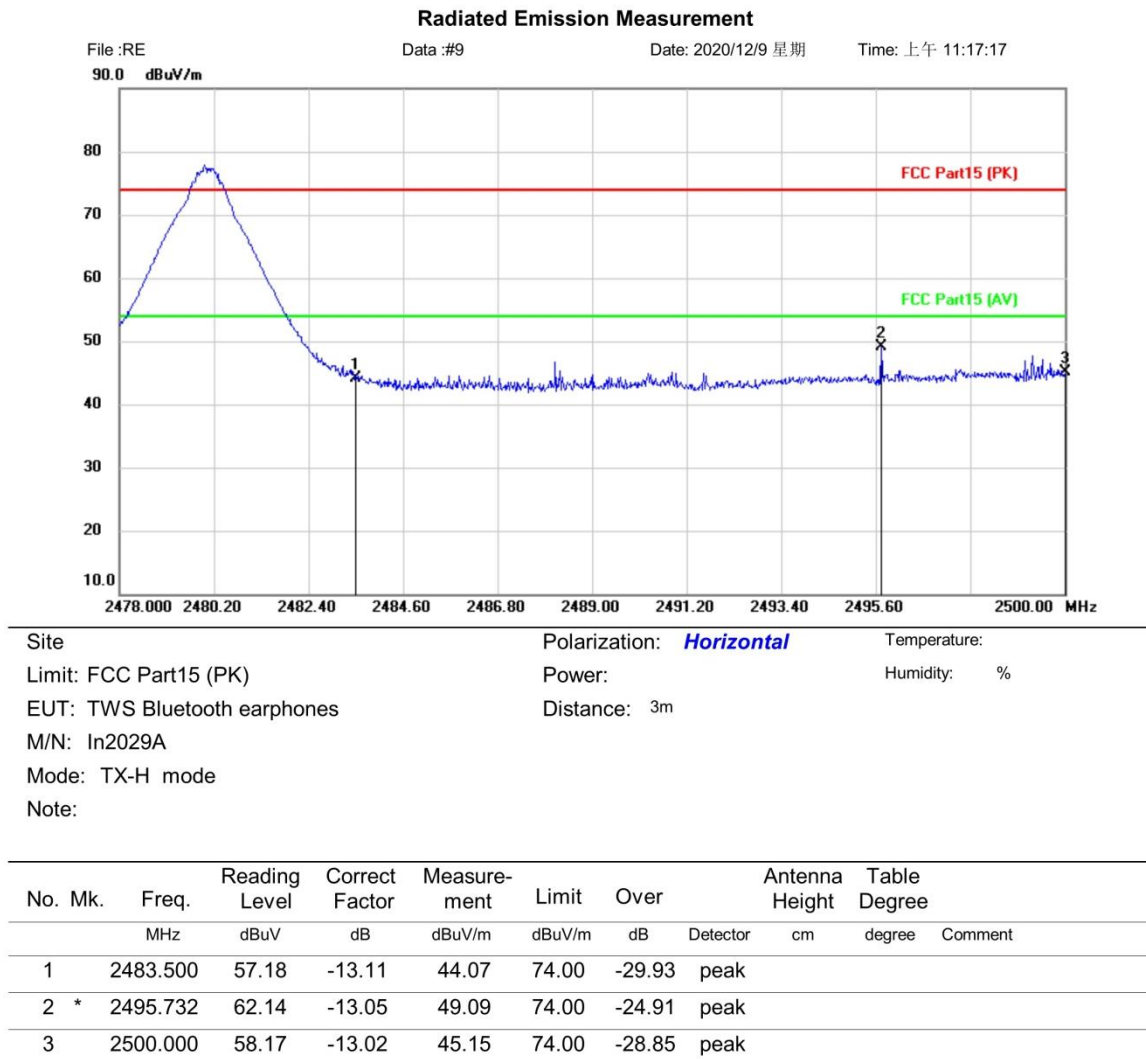


*:Maximum data x:Over limit !:over margin

⟨Reference Only

Test Result: Pass

[TestMode: TX high channel]; [Polarity: Horizontal]

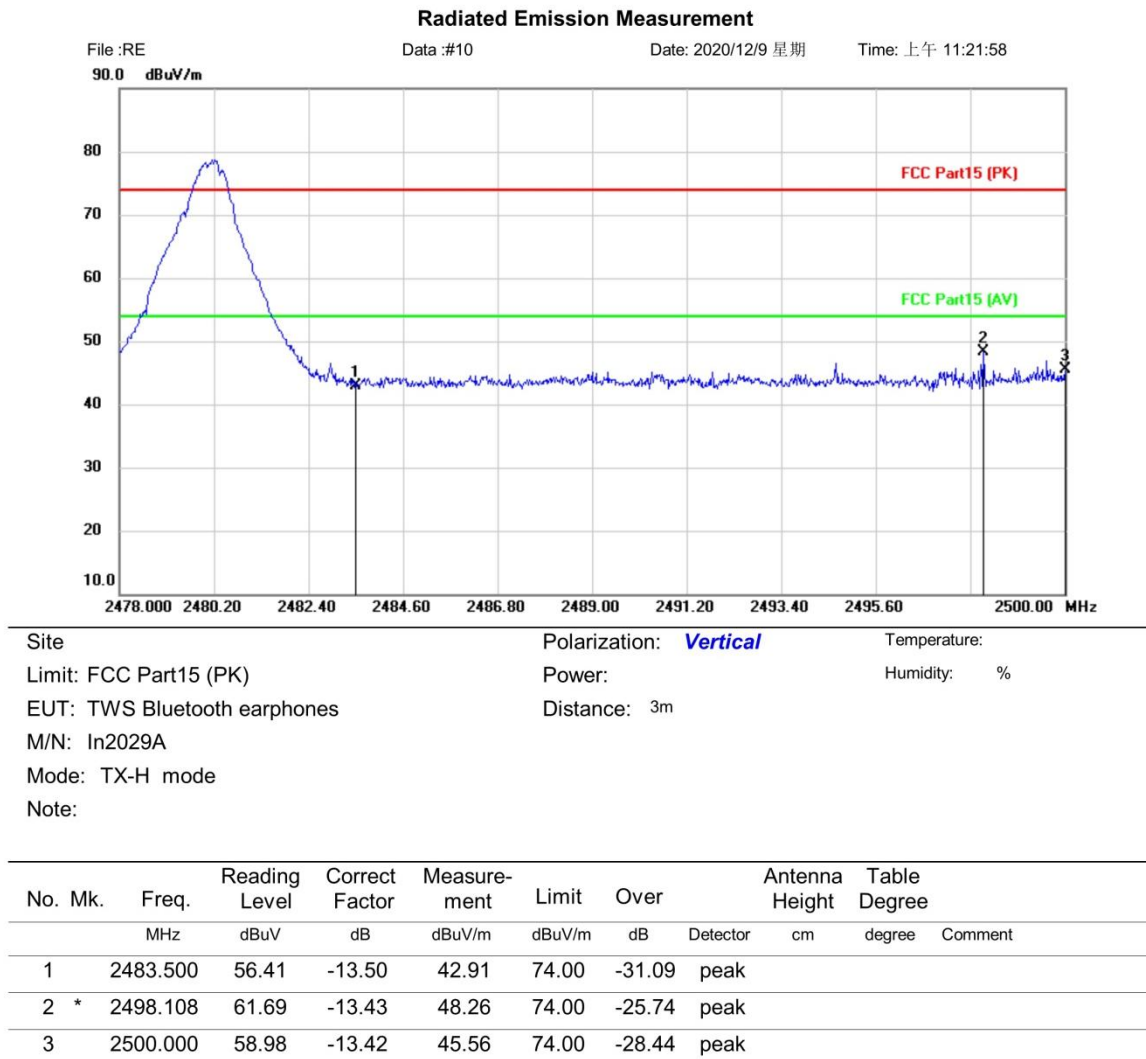


*:Maximum data x:Over limit !:over margin

⟨Reference Only

Test Result: Pass

[TestMode: TX high channel]; [Polarity: Vertical]



*:Maximum data x:Over limit !:over margin

⟨Reference Only

Test Result: Pass

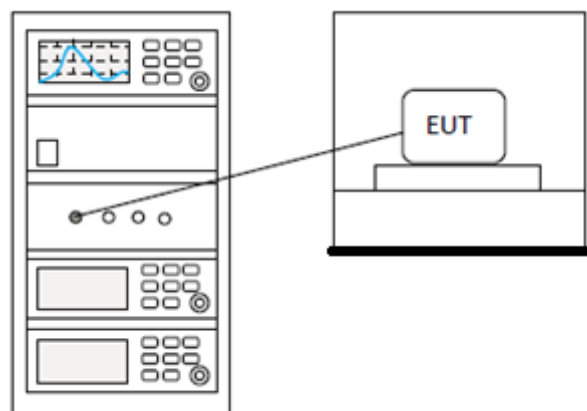
4 CONDUCTED BAND EDGES MEASUREMENT

Test Standard	47 CFR Part 15, Subpart C 15.247
Test Method	ANSI C63.10 (2013) Section 7.8.8 & Section 11.13.3.2
Test Mode (Pre-Scan)	TX
Test Mode (Final Test)	TX
Tester	Eason
Temperature	25°C
Humidity	60%

4.1 LIMITS

Limit:	In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in §15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in §15.209(a) (see §15.205(c)).
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4.2 BLOCK DIAGRAM OF TEST SETUP



4.3 TEST DATA

Pass: Please Refer To Appendix: For Details

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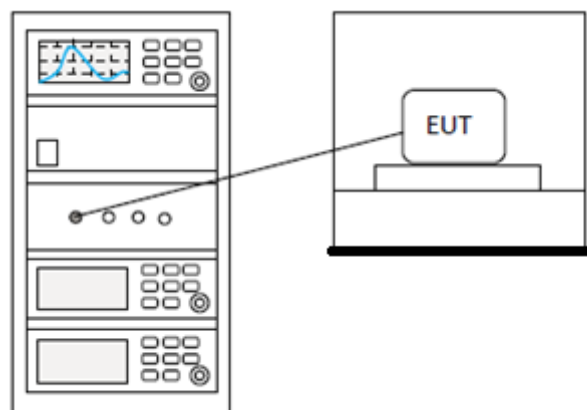
5 DWELL TIME

Test Standard	47 CFR Part 15, Subpart C 15.247
Test Method	ANSI C63.10 (2013) Section 7.8.4
Test Mode (Pre-Scan)	TX
Test Mode (Final Test)	TX
Tester	Eason
Temperature	25℃
Humidity	60%

5.1 LIMITS

Frequency(MHz)	Limit
902-928	0.4S within a 20S period(20dB bandwidth<250kHz)
	0.4S within a 10S period(20dB bandwidth≥250kHz)
2400-2483.5	0.4S within a period of 0.4Smultiplied by the number of hopping channels
5725-5850	0.4S within a 30S period

5.2 BLOCK DIAGRAM OF TEST SETUP



5.3 EST DATA

Pass: Please Refer To Appendix: For Details

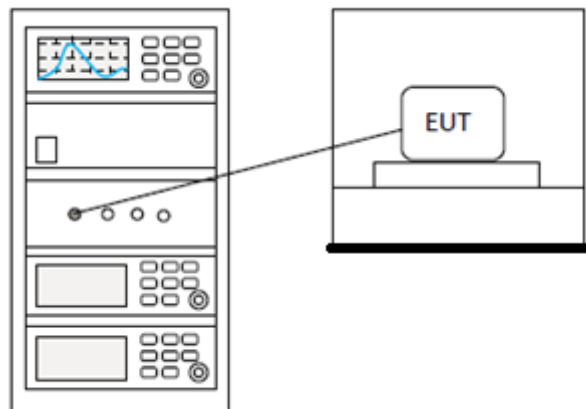
6 HOPPING CHANNEL NUMBER

Test Standard	47 CFR Part 15, Subpart C 15.247
Test Method	ANSI C63.10 (2013) Section 7.8.3
Test Mode (Pre-Scan)	TX
Test Mode (Final Test)	TX
Tester	Eason
Temperature	25℃
Humidity	60%

6.1 LIMITS

Frequency range(MHz)	Number of hopping channels (minimum)
902-928	50 for 20dB bandwidth <250kHz
	25 for 20dB bandwidth ≥250kHz
2400-2483.5	15
5725-5850	75

6.2 BLOCK DIAGRAM OF TEST SETUP



6.3 TEST DATA

Pass: Please Refer To Appendix: For Details

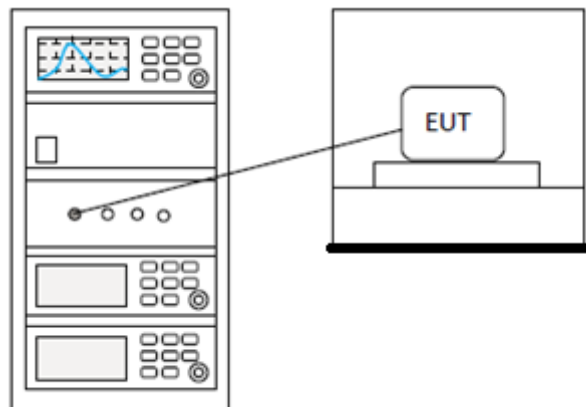
7 CARRIER FREQUENCIES SEPARATION

Test Standard	47 CFR Part 15, Subpart C 15.247
Test Method	ANSI C63.10 (2013) Section 7.8.2
Test Mode (Pre-Scan)	TX
Test Mode (Final Test)	TX
Tester	Eason
Temperature	25°C
Humidity	60%

7.1 LIMITS

Limit:	2/3 of the 20dB bandwidth base on the transmission power is less than 0.125W
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7.2 BLOCK DIAGRAM OF TEST SETUP



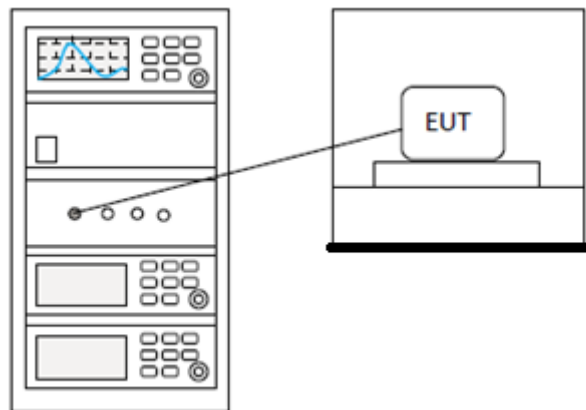
7.3 TEST DATA

Pass: Please Refer To Appendix: For Details

8 20DB BANDWIDTH

Test Standard	47 CFR Part 15, Subpart C 15.247
Test Method	ANSI C63.10 (2013) Section 7.8.7
Test Mode (Pre-Scan)	TX
Test Mode (Final Test)	TX
Tester	Eason
Temperature	25℃
Humidity	60%

8.1 BLOCK DIAGRAM OF TEST SETUP



8.2 TEST DATA

Pass: Please Refer To Appendix: For Details

9 CONDUCTED PEAK OUTPUT POWER

Test Standard	47 CFR Part 15, Subpart C 15.247
Test Method	ANSI C63.10 (2013) Section 7.8.5
Test Mode (Pre-Scan)	TX
Test Mode (Final Test)	TX
Tester	Eason
Temperature	25°C
Humidity	60%

9.1 LIMITS

Frequency range(MHz)	Output power of the intentional radiator(watt)
902-928	1 for ≥ 50 hopping channels
	0.25 for $25 \leq \text{hopping channels} < 50$
	1 for digital modulation
2400-2483.5	1 for ≥ 75 non-overlapping hopping channels
	0.125 for all other frequency hopping systems
	1 for digital modulation
5725-5850	1 for frequency hopping systems and digital modulation

9.2 BLOCK DIAGRAM OF TEST SETUP

